

MOS FIELD EFFECT TRANSISTOR 2SK3482

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3482 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

• Low On-State Resistance

 $R_{DS(on)1} = 33~m\Omega~MAX.~(V_{GS} = 10~V,~I_{D} = 18~A)$ $R_{DS(on)2} = 39~m\Omega~MAX.~(V_{GS} = 4.5~V,~I_{D} = 18~A)$

- Low Ciss : Ciss = 3600 pF TYP.
- Built-in Gate Protection Diode
- TO-251/TO-252 package

ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3482	TO-251		
2SK3482-Z	TO-252		

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	100	V
Gate to Source Voltage (Vps = 0 V)	Vgss	±20	V
Drain Current (DC)	I _{D(DC)}	±36	Α
Drain Current (Pulse) Note1	D(pulse)	±100	Α
Total Power Dissipation (Tc = 25°C)	PT	50	W
Total Power Dissipation (T _A = 25°C)	Рт	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	30	Α
Single Avalanche Energy Note2	Eas	90	mJ

(TO-251)

(TO-252)



Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting Tch = 25°C, Rg = 25 Ω , Vgs = 20 \rightarrow 0 V

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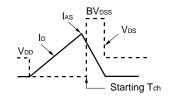


ELECTRICAL CHARACTERISTICS (TA = 25°C)

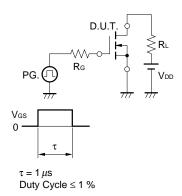
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	Ipss	V _{DS} = 100 V, V _{GS} = 0 V			10	μΑ
Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	y fs	V _{DS} = 10 V, I _D = 18 A	12	23		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 18 A		27	33	mΩ
	RDS(on)2	Vgs = 4.5 V, ID = 18 A		29	39	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V		3600		pF
Output Capacitance	Coss	Vgs = 0 V		360		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		190		pF
Turn-on Delay Time	t d(on)	V _{DD} = 50 V, I _D = 18 A		15		ns
Rise Time	t r	Vgs = 10 V		10		ns
Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		68		ns
Fall Time	t f			6		ns
Total Gate Charge	Q _G	V _{DD} = 80 V		72		nC
Gate to Source Charge	Qgs	Vgs = 10 V		10		nC
Gate to Drain Charge	Q _{GD}	ID = 36 A		19		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 36 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 36 A, VGS = 0 V		70		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		180		nC

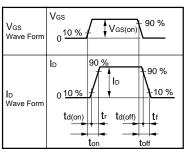
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c|c} \text{D.U.T.} \\ \text{PG.} \\ \hline \\ \text{V}_{\text{GS}} = 20 \rightarrow 0 \text{ V} \\ \end{array} \begin{array}{c} \text{D.U.T.} \\ \hline \\ \text{V}_{\text{DD}} \\ \hline \end{array}$

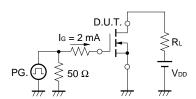


TEST CIRCUIT 2 SWITCHING TIME



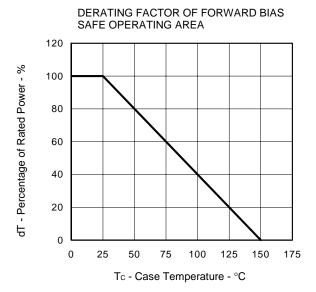


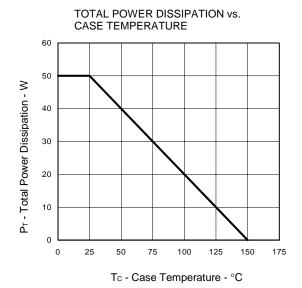
TEST CIRCUIT 3 GATE CHARGE

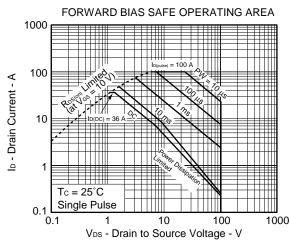


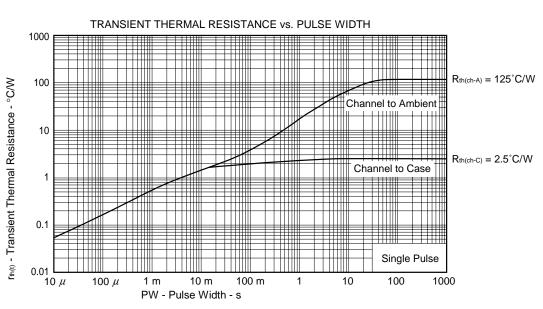


TYPICAL CHARACTERISTICS (TA = 25°C)



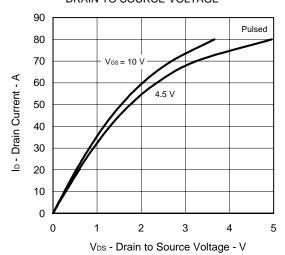




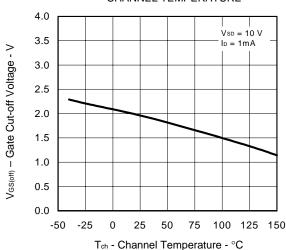


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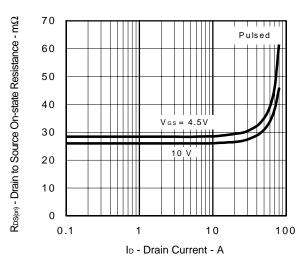
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



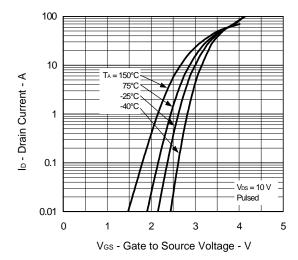
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



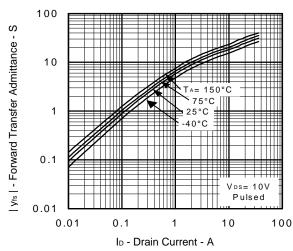
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



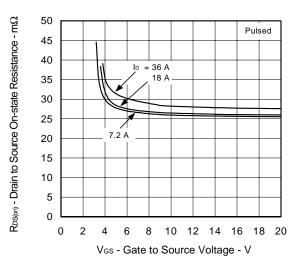
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



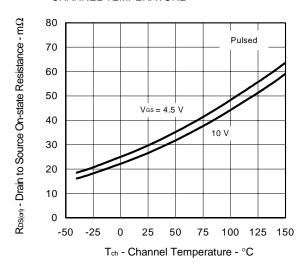
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



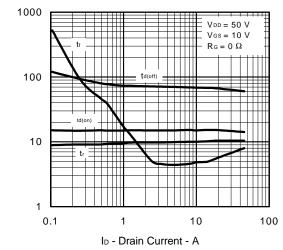


ta(on), tr, ta(off), tr - Switching Time - ns

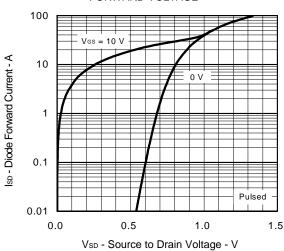
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



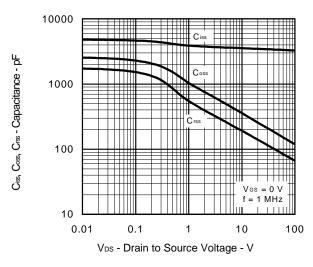
SWITCHING CHARACTERISTICS



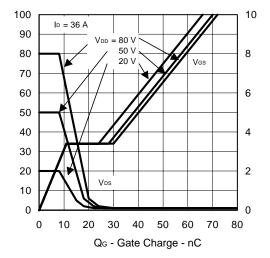
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



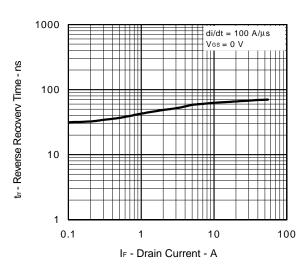
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



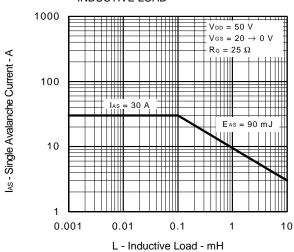
REVERSE RECOVERY TIME vs. DRAIN CURRENT



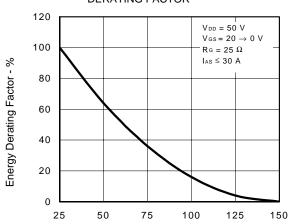
Ves - Gate to Drain Voltage - V

Vps - Drain to Source Voltage - V

SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY DERATING FACTOR

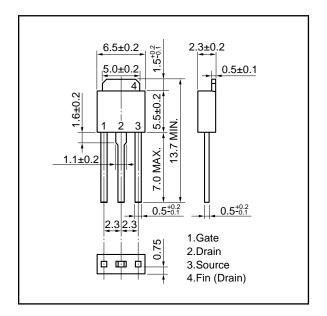


Starting T $_{\text{ch}}$ - Starting Channel Temperature - $^{\circ}\text{C}$

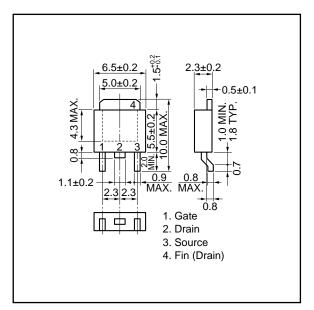


PACKAGE DRAWINGS (Unit:mm)

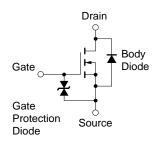
1) TO-251 (MP-3)



2) TO-252 (MP-3Z)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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